

REMOTE SAMPLING ACCESSORIES

Hollow waveguide and fiber optic sampling accessories provide a new dimension of flexibility – expanding the reach of the sample compartment. The probe is flexible and may be taken to the sample; such as an unwieldy object too large to be placed on an accessory or in a chemical reaction vessel. PIKE offers NIR and mid-IR versions of remote sampling probes.

> Mid-IR FlexIR™ Mid-IR Hollow Waveguide Accessory Remote and flexible sampling in the mid-IR spectral region

NIR FlexIR NIR Fiber Optic Accessory Remote sampling in the NIR spectral region

INTRODUCTION AND APPLICATIONS INCLUDED

PIKE TECHNOLOGIES, INC., 6125 COTTONWOOD DRIVE, MADISON, WI 53719 (608) 274-2721 · WWW.PIKETECH.COM · SALES@PIKETECH.COM

Mid-IR FlexIR – Hollow Waveguide Accessory for Remote Infrared Sampling



FEATURES

- Fast, easy identification of solids and liquid samples outside of the sample compartment
- 1 or 2 meter, hollow waveguides offer exceptional durability and high throughput
- Full mid-IR spectral range coverage
- ATR, specular and diffuse reflectance probes for a complete array of sampling applications
- Standard and high-temperature/high-pressure probes for reaction monitoring
- Permanent alignment of sampling probe to the hollow waveguide for consistent analysis results
- MCT or DTGS detector choice for maximum sensitivity and convenience
- Compatible with most FTIR spectrometers

The PIKE FlexIR[™] Mid-IR Hollow Waveguide Accessory is an excellent tool for remote and specific area analysis of a wide variety of samples. Visible surface contamination, small area material identification and bulky materials too large to fit into the FTIR sample compartment are a few of the many samples and application types for the FlexIR accessory.

The FlexIR is designed for ruggedness and wide spectral range. It utilizes a customized optical design with diamond-turned focus optics providing exceptional IR throughput. The hollow waveguides are very durable and free from the typical fracture problems encountered with polycrystalline core fibers. The highly-reflective hollow waveguides transmit maximum energy through the full mid-IR spectral region – eliminating the need for multiple fibers for complete spectrum coverage when chalcogenide or halide probes are used.



Visible defect on manufactured product – Mid-IR FlexIR accessory with ATR probe.

For maximum configurability two FlexIR bases, with an MCT or DTGS detector, are available. Two detector options serve to optimize the signal-to-noise ratio (SNR) against the required spectral range and the application needs. The mid-band MCT style is the most versatile and common detector offered because of its high sensitivity and fast data collection. A DTGS FlexIR base is available for those applications that do not require a high SNR, and benefit from the flexibility and convenience of a room temperature detector. To optimize its performance, the DTGS detector is integrated into the probe. This probe is equipped with a short handle for ease of positioning and sampling.



REMOTE SAMPLING

PIKE TECHNOLOGIES WV

For reaction monitoring, the accessory can be equipped with a high-temperature/high-pressure probe. The probe is made of Hastelloy and features a two-reflection ATR diamond crystal. The 6.35-mm shaft diameter and 178-mm length make it suitable for use in a wide variety of reaction vessels. The probe maximum temperature is 150 °C, with maximum pressure up to 8.3 MPa.



SPECIFICATIONS

Optical Design Accessory Dimensions, MCT Model (W x D x H) Accessory Dimensions, DTGS Model (W x D x H) All reflective, diamond-turned focus optics 153 x 132 x 150 mm (excludes FTIR baseplate and mount) 60 x 67 x 80 mm (excludes FTIR baseplate and mount)

SPECIFICATIONS

Spectral Range ATR	Mid MCT	DTGS
ZnSe	5000–700 cm ⁻¹	5000–550 cm ⁻¹
Ge	5000–700 cm ⁻¹	5000–700 cm ⁻¹
Diamond	5000–700 cm ⁻¹	5000–550 cm ⁻¹
Spectral Range Specular	5000–700 cm ⁻¹	5000–550 cm ⁻¹

SPECIFICATIONS

Standard Probes, MCT

Probe Design Hollow waveguide, full mid-IR reflective Bend Radius, Minimum 150 mm **HWG Dimensions** 1 or 2 m long, 1.6 mm OD, 1.0 mm ID **Diamond ATR Probe** Probe Body Hastelloy C-276 ATR Crystal Monolithic Diamond ATR Crystal Diameter 4.5 mm Number of Reflections 2 Maximum Temperature 150 °C (High-Temperature/High-Pressure) 80 °C (Basic) Maximum Pressure 8.3 MPa (1204 psi) 178 mm length, 6.35 mm diameter Shaft Dimensions Standard ATR Probes - MCT Version Handle: Aluminum Probe Body Sampling Tip: Stainless Steel Maximum Sample Depth 60 mm ATR Crystal Types Diamond/ZnSe, ZnSe, and Ge ATR Crystal Diameter 4.5 mm Maximum Operating Diamond/ZnSe: Ambient Temperatures -ZnSe: 60 °C MCT Version Germanium: 60 °C Maximum Operating Diamond/ZnSe: Ambient Temperatures -ZnSe: Ambient DTGS Version Germanium: Ambient Specular Reflectance Probe Gold-coated, 20 degree AOI **Diffuse Reflectance Probe** Gold-coated, 2.5 mm port Shaft Dimensions of all 102 mm length, 22 or 12 mm diameter

ORDERING INFORMATION

MID-IR FLEXIR BASE WITH MCT DETECTOR

PART NUMBER DESCRIPTION

45-30XX	Mid-IR	FlexIR	Base	for	MCT	Version

Notes: Replace XX with your spectrometer's Instrument Code. <u>Click for List</u> \geq The FlexIR is provided with base optics mounting for the sample compartment of your FTIR spectrometer. An on-board MCT detector must be selected (below). Your FTIR spectrometer must be capable of interfacing with an external detector.

HOLLOW WAVEGUIDE MCT DETECTORS

(must select one)

(

PART NUMBER	DESCRIPTION
045-3200	Mid-band MCT Detector
045-3100	Narrow-band MCT Detector

PROBES FOR MID-IR FLEXIR WITH MCT DETECTOR

(select one or more)

PART NUMBER	DESCRIPTION
045-4200	Diamond ATR Probe, basic, 1 m
045-4300	Diamond ATR Probe, High-Temperature/High-Pressure, 1 m
045-4100	Diamond/ZnSe ATR Probe, 1 m length, 22 mm diameter
045-4102	Diamond/ZnSe ATR Probe, 2 m length, 22 mm diameter
045-4010	ZnSe ATR Probe, 1 m length, 22 mm diameter
045-4012	ZnSe ATR Probe, 2 m length, 22 mm diameter
045-4050	Ge ATR Probe, 1 m length, 22 mm diameter
045-4052	Ge ATR Probe, 2 m length, 22 mm diameter
045-4030	Specular Reflectance Probe, 1 m length, 22 mm diameter
045-4032	Specular Reflectance Probe, 2 m length, 22 mm diameter
045-4020	Diffuse Reflectance Probe, 1 m length, 22 mm diameter
045-6000	Diamond/ZnSe Probe, 1 m length, 12 mm diameter
045-6100	ZnSe Probe, 1 m length, 12 mm diameter
045-6200	Ge Probe, 1 m length, 12 mm diameter

Notes: Sampling probes are fixed to the hollow waveguides for maximum sampling reproducibility. Diffuse and specular probes are open-tipped and are not suitable for powder or liquid sampling.

MID-IR FLEXIR BASE WITH DTGS DETECTOR

PART NUMBER DESCRIPTION

045-35 <mark>XX</mark>	Mid-IR	FlexIR	Base for	or D	TGS \	Version

Notes: Replace XX with your spectrometer's Instrument Code. <u>Click for List ></u> The FlexIR is provided with base optics mounting for the sample compartment of your FTIR spectrometer. Your FTIR spectrometer must be capable of interfacing with an external detector. The DTGS detector is integrated into the probe.

PROBES FOR MID-IR FLEXIR WITH DTGS DETECTOR

(must select one or more)PART NUMBERDESCRIPTION045-5100Diamond/ZnSe ATR Probe, 1 m045-5010ZnSe ATR Probe, 1 m045-5050Ge ATR Probe, 1 m045-5030Specular Reflectance Probe, 1 m

Notes: Sampling probes are fixed to the hollow waveguides for maximum sampling reproducibility. DTGS detector is integrated into the probe. Specular probe is open-tipped and is not suitable for powder or liquid sampling.

HOLLOW WAVEGUIDE PROBE HOLDERS

PART NUMBER	DESCRIPTION
045-3400	Adjustable Probe Holder
045-3410	Standard Probe Holder

Note: Probe holders may be used with all standard hollow waveguide probes.

Standard Probe Holder

NIR FlexIR – NIR Fiber Optic Accessory for Fast and Remote Sample Identification





- Fast, easy identification of solids and liquid samples in situ
- 2 meter, low-OH fibers providing exceptional throughput and excellent spectral data with short analysis time
- Spectral range from 1.0 to 2.5 microns (10,000 to 4000 cm⁻¹)
- Integrated, high-sensitivity, extended range InGaAs detector with electronics connection for your FTIR spectrometer
- Standard SMA connectors providing maximum flexibility with fiber probes
- Standard diffuse reflectance sampling tip with inert sapphire window for solid samples
- Optional transflectance sampling tip for liquid samples
- Compatible with most FTIR spectrometers configured for NIR operation

The PIKE Near-IR (NIR) FlexIR[™] fiber optic accessory is an excellent tool for remote and speedy analysis of a wide variety of materials. Powders, plastics, coatings, and liquid samples are readily measured – typically within 30 seconds. The NIR FlexIR is ideal for performing incoming QC of materials used in pharmaceutical, polymer, and chemical manufacturing.

NIR sampling is fast and efficient as it eliminates the need for sample preparation. The NIR FlexIR accessory further speeds analysis since the probe tip simply contacts the sample, often in drums, and the spectrum is collected. Powdered samples packaged within a plastic bag can be analyzed without removal from the bag, which further speeds analysis time and eliminates analyst exposure to chemical materials.

The NIR FlexIR is designed for maximum throughput and performance. The fiber optic cable is directly coupled to the integrated indium gallium arsenide (InGaAs) detector – eliminating energy loss due to additional transfer optics and beam divergence.

With the optional Liquids Sampling Tip, it is easy to identify incoming liquids by inserting the wand tip into the liquid sample and collecting its spectrum.

The NIR FlexIR accessory is built and tested for optimum performance for your FTIR spectrometer.



Spectra of incoming pharmaceutical materials measured and verified with the NIR FlexIR accessory.





ORDERING INFORMATION

PART NUMBER	DESCRIPTION
045-10XX	FlexIR NIR Fiber Optic Accessory Includes base optics mounting for the sample compartment of your FTIR spectrometer, electronic cabling, diffuse reflectance probe and probe stand.

Notes: Replace XX with your spectrometer's Instrument Code. <u>Click for List ></u> Your FTIR spectrometer must be configured with NIR beamsplitter and NIR source for optimum performance of the FlexIR accessory. Your FTIR spectrometer must be capable of interfacing with an external detector.

SAMPLING OPTIONS

Noto, The Liquid	le Compling Tip is serous mounted and posily syshenged with t
045-2002	Liquids Sampling Tip for FlexIR, 2.0 mm pathlength
045-2000	Liquids Sampling Tip for FlexIR, 1.5 mm pathlength
045-2001	Liquids Sampling Tip for FlexIR, 1.0 mm pathlength
PART NUMBER	DESCRIPTION

Note: The Liquids Sampling Tip is screw-mounted and easily exchanged with the solids sampling tip on the FlexIR sampling probe.

REPLACEMENT PARTS

PART NUMBER	DESCRIPTION
045-2010	Diffuse Reflectance Tip for NIR FlexIR probe
045-7051	NIR FlexIR Probe Stand

Mid-IR Remote Sampling – Introduction and Applications

Fourier transform infrared (FTIR) remote sampling offers a viable solution for the analysis of samples which are not conducive to the use of traditional FTIR sampling accessories due to constraints posed by the size of a bench-top instrument's sample compartment or the nature of the sample. Taking an IR probe to a sample is desirable in numerous applications and a necessity in others. Examples of remote IR sampling may be found across many fields. In the fine arts, priceless paintings and artifacts may be analyzed with limited sample handling. Mid-IR analysis of intractable samples such as large painted panels may be conducted. Biomedical applications encompass soft tissue and skin analysis. In chemical production, remote sampling allows for reaction monitoring and the analysis of samples restricted to glove boxes and fume hoods.

PIKE Technologies offers the next generation of commerciallyavailable FTIR remote sampling accessories with the Mid-IR FlexIR. Hollow waveguides (HWGs), the cornerstone of these mid-IR remote sampling accessories, offer enhanced performance characteristics compared to traditional mid-IR optical fibers. The most popular type of HWGs consists of reflective coated silica tubing. The inner portion of silica tubing is coated with Ag followed by converting some of the Ag to AgI to form a dielectric layer, which exhibits a highly reflective and very smooth surface. The exterior of the silica tubing is coated with acrylate polymer to provide additional strength.



Hollow waveguide

HWGs used in the design of the Mid-IR FlexIR accessory address many of the limitations found with the use of traditional chalcogenide glass and silver halide polycrystalline fibers. Chalcogenide fibers exhibit a strong absorption band located near 2170 cm⁻¹ due to S-H or Se-H bonds; as a consequence, the signalto-noise ratio (SNR) in this spectral region is significantly decreased. To address this issue, two different fiber types, chalcogenide and silver halide, are often employed to generate a full spectral range. The chalcogenide fiber generally used in mid-IR spectroscopy covers approximately 6500–2250 cm⁻¹ and 2050–1000 cm⁻¹ while the silver halide fiber covers 2100–600 cm⁻¹. In contrast, HWGs are capable of spanning a wide spectral range from 11,000 to 700 cm⁻¹ eliminating the need for a complementary fiber set. The spectral range of the Mid-IR FlexIR accessory is dependent on the probe type and the configured detector.

Durability of traditional fibers has been a concern and a hindrance in past mid-IR remote sampling accessories. Additionally, intrinsic flaws originating during the manufacture of glass fibers significantly increase fiber fragility, and may often result in catastrophic failure under routine application use. Furthermore, the bend radius of traditional fibers are limited. Contrary to these properties, HWGs offer a robust means of delivering and collecting IR radiation and offers a smaller bend radius. For ultimate flexibility the Mid-IR FlexIR offers a choice of detector, either a liquid nitrogen MCT detector for applications that require high sensitivity or a DTGS detector for applications that require less sensitivity yet desire the convenience of a room temperature detector. Two models of MCT detectors are available (narrow-band and mid-band) to allow the optimization of signal-to-noise ratio and spectral range. The MCT detector is mounted on the base optics while the DTGS detector is nested in the probe tip.

The sample probe is permanently aligned to the HWG for consistent analysis results. A variety of probes are available covering ATR, diffuse reflectance, and specular reflectance sampling techniques. Three ATR crystal offerings are zinc selenide (ZnSe), germanium, and diamond/zinc selenide composite. Fiber length is 1 or 2 m.

To illustrate the diverse capabilities of the newest technology in mid-IR remote sampling – the Mid-IR FlexIR, three application examples will be presented highlighting applications using attenuated total reflectance (ATR), diffuse reflectance and specular reflectance sampling probes.

Biomedical Application: ATR Probe

The simplicity of ATR sampling has led to its use in numerous biomedical applications. Confining the ATR crystal sampling surface to an FTIR sample compartment limits in vivo studies.

Remote ATR sampling, however, expands the flexibility of FTIR studies and applications in this field. For example, remote ATR sampling makes it possible to investigate chemical diffusion through the skin, residual chemicals retained on the skin from body lotions and washes and the investigation of skin aberrations.

The objective of this biomedical application was to investigate residual chemicals found on human skin after the application of a commercially-available sunscreen spray. A spectrum was collected before and after the application of the skin care product using the FlexIR ZnSe ATR probe.

Spectral data of untreated skin clearly shows the IR chemical signature of skin including the amide I and amide II bands at 1650 and 1550 cm⁻¹, respectively. The result from spectral subtraction allows for the investigation of the sunscreen chemicals remaining on the skin (Figure 1). Capabilities of collecting in vivo data allow for the optimization of formulations and the study of time-based efficacy of existing products and those in the product development stage.



Figure 1. Spectra of untreated and treated skin.

REMOTE SAMPLING

Intractable Panels: Diffuse Reflectance and Specular Reflectance

Reflective-type measurements may be classified as either diffuse or specular. Coatings and thin films on reflective substrates are candidates for specular reflectance measurements. Using this sampling technique, the reflected beam from the sample is collected at an angle of incidence equal to that of the incoming beam as it is delivered to the sample. Diffuse samples scatter the reflected beam across a wide range of angles and in IR sampling must be gathered using a collection optic.

To illustrate non-destructive mid-IR testing using remote sampling, two intractable samples were analyzed. One sample consisted of a coating on a smooth reflective surface, conducive to specular reflectance measurements. The other sample type had a painted diffuse surface. Figure 3 shows the spectrum of a coating on a smooth reflective surface obtained by using the Mid-IR FlexIR configured with a specular reflectance probe, and Figure 4 shows spectra of painted diffuse panels collected with the diffuse reflectance probe. The two diffuse painted panels clearly show differing chemical properties. In each sample the high SNR results in quality spectra. The spot size of both probes is 2.5 mm in diameter allowing for concise measurements of small defects. Remote sampling offers a convenient method of non-destructive analysis.



Figure 3. Spectrum of a coating on aluminum.



Figure 4. Spectrum of a panel with diffuse finish.

Conclusions

HWGs bring new technology to mid-IR remote sampling accessories. The diversity of sampling probes covering ATR, diffuse reflectance and specular reflectance used in conjunction with HWGs and high precision optics offers the capability to collect quality spectra of a wide range of samples, which may be prohibited with traditional in-compartment FTIR sampling accessories.

ORDERING TERMS, CONTACT INFORMATION AND GUARANTEE

PART NUMBERS AND PRICE

The PIKE price list includes accessories that may be used with a variety of makes and models of spectrometers. Please specify the part number and description when ordering, including your instrument type and model number. <u>Click here</u> for a list of spectrometer and spectrophotometer instrument codes. When placing an order, substitute these codes for the final two digits (XX) in the accessory part number.

PIKE Technologies is continually extending the accessory product range. If you are unable to find a required item, please contact us to discuss your needs. We will be glad to assist.

PAYMENT TERMS

Purchase Order Number, cash in advance, MasterCard and Visa are acceptable. Payment is net 30 days, and shipments are FOB Madison, WI USA. Freight charges are prepaid and added to your invoice. If you wish to pay freight charges, please specify this on your order. Prepayment is required for international customers.

INTERNATIONAL HANDLING FEE

For orders placed from outside the United States or Canada, a handling fee of \$40 will apply per order to cover the costs associated with the additional documentation and bank charges required for international shipments.

WAYS TO ORDER

Many products are available for purchase directly through our website. These items are marked on our website with a red shopping cart icon.

Please include the following information when placing an order: your name, phone number, product part number, quantity, ship to address, bill to address, purchase order number and spectrometer model on which the accessory will be used.

Orders may be placed via mail, phone, fax, e-mail or on our website. We accept Visa and Mastercard via phone and direct online purchases. For security purposes, do not send credit card information via e-mail. An electronic order form is available on our website (for P.O. Numbers only – do not use this form for credit card orders). There is no minimum order requirement. Please use the following addresses and phone/fax numbers when placing your orders:

> PIKE Technologies, Inc. 6125 Cottonwood Drive Madison, WI 53719 (608) 274-2721 (TEL) (608) 274-0103 (FAX) orders@piketech.com (E-MAIL) www.piketech.com

DELIVERY

The delivery/shipment date is confirmed upon receipt of an order. Special requirements and custom accessories are subject to different lead times. Please contact us for price quotes and delivery information on these products.

GUARANTEE

All PIKE products are guaranteed to be free from defects in material and workmanship for a period of 12 months from the date of shipment. Should you be dissatisfied, or have any queries, please contact us immediately and we will promptly repair or replace the product at no charge.

PRODUCT RETURNS

Please contact PIKE to receive your Return Material Authorization (RMA) number if you wish to return any of our products. A restocking fee may apply. Customers are responsible for shipping charges for all returned products. For products under warranty, back-to-customer shipping charges will be covered by PIKE. Please do not return any products without obtaining the RMA number first.

TECHNICAL ASSISTANCE

PIKE Technologies offers comprehensive technical assistance. Please contact us via mail, phone, fax or e-mail with your questions.

INTERNATIONAL DISTRIBUTION

PIKE Products are available worldwide. Call or send us an e-mail and we will provide you with an address of the sales office closest to your location. All exports are handled in accordance with the US Export Administration Regulations.

PIKE ON THE WEB

Visit our web site to find out more information about new products, up-to-date PIKE news, pricing, and to see the latest copy of the PIKE Reflections Newsletter! <u>www.piketech.com</u> • <u>info@piketech.com</u>

Customer satisfaction is very important to all of us here at PIKE Technologies, Inc. We have hopefully made the ordering process very fast and easy for you. If you have any questions or concerns about our products or services, please don't hesitate to contact us. We will be happy to make adjustments to fit your needs.

Products and prices are subject to change without notification.

©2017 PIKE Technologies, Inc.

Horizon MB[™] belongs to ABB; Luer-Lok[™] belongs to Becton Dickenson; Equinox[™], IFS[™], Quick-Lock[™], Tensor[™], Vector and Vertex[™] belongs to Bruker Optics Inc.; CAB-O-SIL[®] belongs to Cabot Corporation; Pyrex[®] belongs to Corning Glass Works; Delrin[®], Kalrez[®], Teflon[®], and Viton[®] belong to E.I. du Pont de Nemours and Company; Interspec belongs to Interspectrum OU; Spectra Manager[™] belongs to Jasco, Inc; Winspec[™] belongs to JEOL; EMCOMPRESS[®] belongs to JRS Pharma; InfraLUM[®] and SpectraLUM/Pro[®] belongs to Lumex Ltd; Visual BASIC[™] and Windows belongs to Microsoft Corporation; Fluorolube[®] belongs to OxyChem Corporation; Spectrum[™] and Spectrum 10[™] belongs to PerkinElmer, Inc; Nujol[™] belongs to Schering-Plough; IRPrestige[™] belongs to Shimadzu Corporation; Swagelok[®] belongs to Swagelok Company; Avatar[™], Genesys[™], Impact[™], is[™]5, is[™]10, is[™]50, Magna-IR[™], Nexus[™], Nicolet[™], WinFirst[™], OMNIC[™] and Protégé[™] belong to Thermo Fisher Scientific; Excalibur[™], Resolutions Pro[™] and Scimitar[™] belong to Varian, Inc. All other trademarks are the property of PIKE Technologies.

FTIR AND UV-VIS INSTRUMENT CODES

When ordering a PIKE accessory, replace the XX or XXX portion of the product's part number with your spectrometer's instrument code below. For assistance, please contact a PIKE customer service representative at (608) 274-2721 or sales@piketech.com.

FTIR INSTRUMENT CODES (XX)

ABB Bomem	
FTLA2000-100 (Arid Zone)	80
Michelson 100, MB Series	81
MB 3000	82
Agilent	
Excalibur [™] , Scimitar [™] , FTS, 600-IR Series	10
Excalibur™, Scimitar™, 600-IR Series with recognition	13
Analect (See Hamilton Sundstrand)	
Bio-Rad (See Agilent)	
Bruker Optics	
IFS™, Vector™, Equinox™ Series.	50
Tensor™, Vertex™ with recognition (Quick-Lock)	51
Buck Scientific	
M500	65
Digilab (See Agilent)	
Hamilton Sundstrand AIT	
Diamond 20	60
Horiba	
7000 Series	35
Interspectrum	
Interspec 200-X	90
Jasco	
300/600 Series	56
400	57
4000/6000 Series	58
JEOL	
Winspec [™] Series	46
Lambda Scientific	
Lambda FTIR 7600	66
Lambda FTIR 8600	64
Lumex	
INFRALUM FT-02, FT-08	67
Mattson (See Thermo Electron)	
Midac	
M Series	30
Nicolet (See Thermo Electron)	
Oriel	95
Optical Table	99

PerkinElmer

1700 Series	70
Spectrum™ GX, 2000	71
Spectrum BX / RX, 1600, Paragon 1000	73
Frontier, Spectrum One, 65, 100, 400 with recognition	74
Spectrum Two with recognition	75
Shimadzu	
8300, 8400 Series, IRPrestige™-21, IRAffinity-1s	15
IRPrestige [™] -21, IRAffinity-1s with recognition (QuickStart)	16
IRTracer [™] -100	18
IRTracer [™] -100 with recognition	19
Thermo Electron / Nicolet / Mattson	
Infinity, Galaxy, RS Series	20
Genesis™, Satellite, IR 300	21
Impact [™] 400, Magna, Protege [™] , 500 / 700 Series	40
Avatar™, Nexus™, Nicolet™, iS™10, iS™50	40
Model 205/210	41
Nicolet iS™5	42
Avatar, Nexus, Nicolet Series with recognition (Smart)	47
Varian (see Agilent)	

UV-VIS INSTRUMENT CODES (XXX)

Agilent/Varian

Cary 50	100
Cary 60	111
Cary 100, 300	110
Cary 4000, 5000, 6000i	120
Jasco	
600 Series	600
Optical Table	999
PerkinElmer	
Lambda 650, 750, 850, 950 and 1050	700
Lambda 25, 35, 45	730
Shimadzu	
1600 and 1700	200
1800 Series	210
2600	240
3600	220
Thermo Fisher Scientific	
Evolution 300/600	400
Evolution 200	410





6125 Cottonwood Drive, Madison, WI 53719 (608) 274-2721 (Tel), (608 274-0103 (Fax) www.piketech.com · sales@piketech.com